

# Lonten N-channel 500V, 5A Power MOSFET

### **Description**

The Power MOSFET is fabricated using the advanced planar **VDMOS** technology. The resulting device has low conduction resistance, superior switching performance and high avalanche energy.

#### **Features**

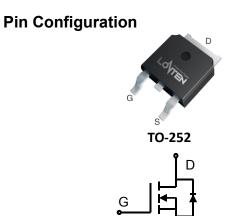
- Low R<sub>DS(on)</sub>
- Low gate charge (typ. Q<sub>g</sub> =13.2nC)
- 100% UIS tested
- RoHS compliant

### **Applications**

- Power factor correction.
- Switched mode power supplies.
- LED driver.

### **Product Summary**

 $\begin{array}{ll} V_{DSS} & 500V \\ I_D & 5A \\ R_{DS(on),max} & 1.6\Omega \\ Q_{g,typ} & 13.2nC \end{array}$ 



N-Channel MOSFET



### **Absolute Maximum Ratings**

Parameter		Symbol Value		Unit	
Drain-Source Voltage		V <sub>DSS</sub>	500	V	
Continuous drain current 1)	( T <sub>C</sub> = 25°C )	I <sub>D</sub>	5	A	
	$(T_C = 100^{\circ}C)$		3	A	
Pulsed drain current 2)		I <sub>DM</sub>	20	A	
Gate-Source voltage		V <sub>GSS</sub>	±30	V	
Avalanche energy, single pulse 33	1	Eas	211	mJ	
Power Dissipation		P <sub>D</sub>	80	W	
Operating and Storage Temperature Range		T <sub>J</sub> , T <sub>STG</sub>	-55 to +150	°C	
Continuous diode forward current		Is	5	A	
Diode pulse current		I <sub>S,pulse</sub>	50	A	

#### **Thermal Characteristics**

Parameter	Symbol Value		Unit	
Thermal Resistance, Junction-to-Case	R <sub>θJC</sub>	1.57	°C/W	
Thermal Resistance, Junction-to-Ambient 4)	R <sub>0JA</sub>	96.05	°C/W	
Soldering temperature, wavesoldering only allowed	T <sub>sold</sub>	260	°C	
at leads. (1.6mm from case for 10s)				



**Package Marking and Ordering Information** 

Device	Device Device Package		Units/Reel	
LNG5N50	TO-252	LNG5N50	2500	

#### Electrical Characteristics T<sub>c</sub> = 25°C unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Тур.	Max.	Unit
Static characteristics	1					
Drain-source breakdown voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =0.25mA	500	-	-	V
Gate threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =0.25mA	2.0	-	4.0	V
Drain cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> =500V, V <sub>GS</sub> =0 V,T <sub>j</sub> = 25°C	-	-	1	μΑ
Gate leakage current, Forward	I <sub>GSSF</sub>	V <sub>GS</sub> =20V, V <sub>DS</sub> =0V	-	-	100	nA
Gate leakage current, Reverse	I <sub>GSSR</sub>	V <sub>GS</sub> =-20V, V <sub>DS</sub> =0V	-	-	-100	nA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =10 V, I <sub>D</sub> =2.5A				
		T <sub>j</sub> = 25°C	-	1.38	1.6	Ω
		T <sub>j</sub> = 150°C	-	3.17		
Dynamic characteristics						
Input capacitance	Ciss	V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0 V,	-	549.83	-	
Output capacitance	Coss	f = 250kHz	-	56.73	-	pF
Reverse transfer capacitance	C <sub>rss</sub>		-	2.93	-	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 250V, I <sub>D</sub> = 5A	-	37.9	-	
Rise time	t <sub>r</sub>	$R_G = 10\Omega$ , $V_{GS}=10V$	-	7.2	-	ns
Turn-off delay time	t <sub>d(off)</sub>		-	18.0	-	
Fall time	t <sub>f</sub>		-	8.1	-	
Gate charge characteristics	'		,			
Gate to source charge	Q <sub>gs</sub>	V <sub>DD</sub> =400V, I <sub>D</sub> =2.5A	-	2.6	-	
Gate to drain charge	Q <sub>gd</sub>	V <sub>GS</sub> =0 to 10V	-	5.8	-	nC
Gate charge total	Qg		-	13.2	-	
Gate plateau voltage	V <sub>plateau</sub>		-	4.7	-	V
Reverse diode characteristics						
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>F</sub> =5A	-	-	1.3	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> =250V, I <sub>F</sub> =2.5A,	-	201.4	-	ns
Reverse recovery charge	Qrr	dI <sub>F</sub> /dt=100 A/μs	-	832.8	-	μC
Peak reverse recovery current	Irm		-	6.89	-	Α

#### Notes:

- 1. Drain current limited by maximum junction temperature.
- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3.  $I_{AS}$ =6.5A, L=10mH,  $V_{DD}$ =60V, Starting  $T_j$ = 25° C.
- 4. The value of  $R_{\text{thJA}}$  is measured by placing the device in a still air box which is one cubic foot.

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### **Electrical Characteristics Diagrams**

Figure 1. Typ. Output Characteristics

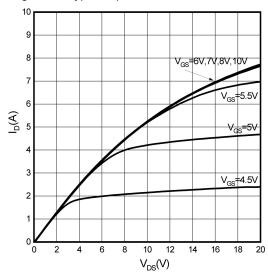


Figure 3. On-Resistance vs. Drain Current

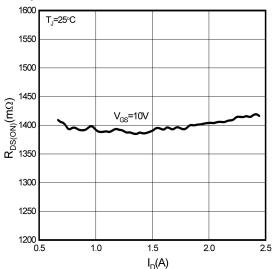


Figure 5.Breakdown Voltage vs.Temperature

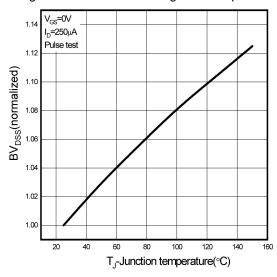


Figure 2. Transfer Characteristics

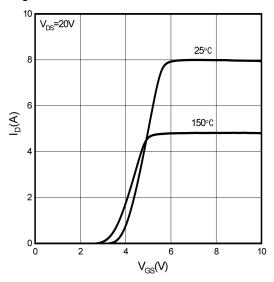


Figure 4.On-Resistance vs.Temperature

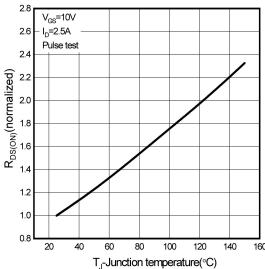
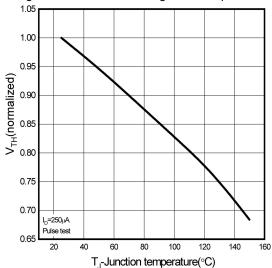
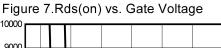


Figure 6.Threshold Voltage vs.Temperature







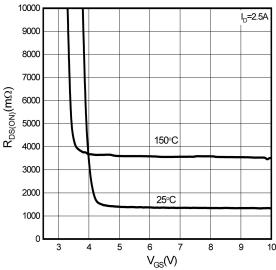


Figure 9. Capacitance Characteristics

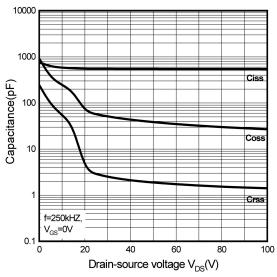


Figure 11.Drain Current Derating

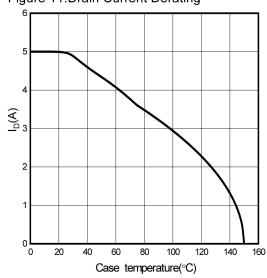


Figure 8.Body-Diode Characteristics

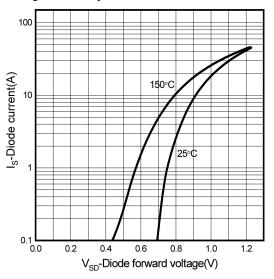


Figure 10. Gate Charge Characteristics

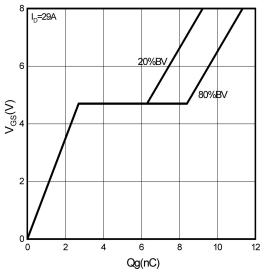


Figure 12. Power Dissipation vs. Temperature

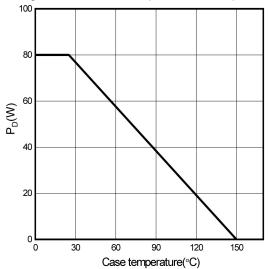




Figure 13. Safe Operating Area

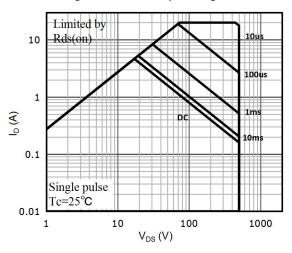
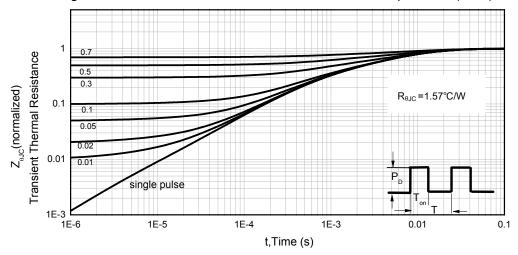


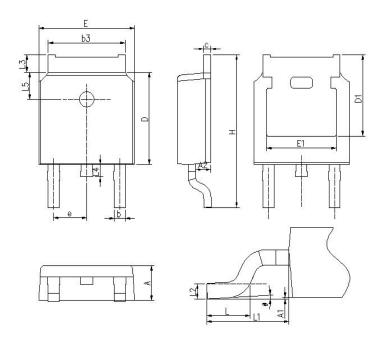
Figure 14. Normalized Maximum Transient Thermal Impedance ( $R_{\text{thJC}}$ )



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# **Mechanical Dimensions for TO-252**

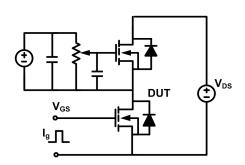


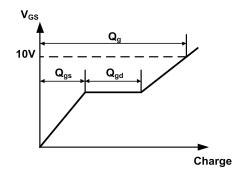
DIMENSIONS IN				
MILLITMETERS				
SYMBOL	MIN	MAX		
A	2. 18	2.4		
A1	-	0.2		
A2	0.9	1. 17		
b	0.65	0.9		
b3	4. 95	5. 5		
c	0. 43 0. 89			
D	5. 97	6. 22		
D1	5. 21	-		
Е	6. 35	6.8		
E1	4. 32	-		
е	2. 286BSC			
Н	9.4 10.5			
L	0.38	1.78		
L1	2. 90BSC			
L2	0. 51BSC			
L3	0.88 1.28			
L4	_	1.02		
L5	1. 65 1. 95			
θ	0°	10°		



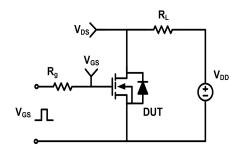
### **Test Circuit & Waveforms**

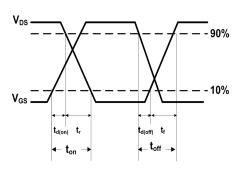
## Gate Charge Test Circuit & Waveform



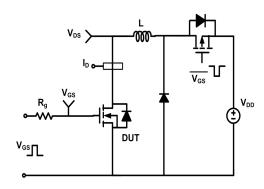


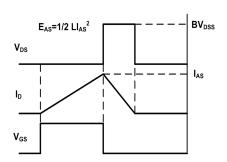
Resistive Switching Test Circuit & Waveform



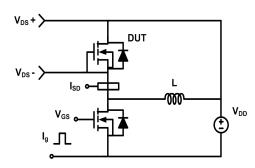


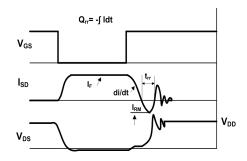
### Unclamped Inductive Switching (UIS) Test Circuit & Waveform





Diode Recovery Test Circuit & Waveform







#### **Version Information**

LNG5N50

Revision:2023-07-31,Rev 1.0

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